

TEST / CALIBRATION REPORT

Type Test Report for MECO Moving Coil Panel Meter

Testing as per IS 1248:1993, Category II



ELECTRONICS REGIONAL TEST LABORATORY (WEST)

MINISTRY OF COMMUNICATIONS & INFORMATION TECHNOLOGY, (STQC Dte.)

Government of India

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MEMORANDUM

The Test/Calibration Report issued by ERTL (W) is a record of the measurements conducted on the products submitted to it for testing / calibration and the results thereof. Unless otherwise specified in the report, the results are applicable only to those products which have been tested / calibrated and do not apply to other products even though declared to be identical.

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- ERTL (W) shall not be liable for any change in test / calibration data and performance specification on account of malfunctioning of the standard / instrument / equipment due to any damage caused to it after the report, in respect of it has been issued.
- 2. The reprot shall not be regarded in any way diminishing the normal contractual responsibilities / obligations between the customer and ERTL (W).
- 3. The results reported in this report are valid only at the time of and under the stated conditions of the measurements.

ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF INFORMATION TECHNOLOGY (STQC Dte.)	REPORT NO. ERTL(W	/)/2002E&S	285
SUBJECT: TESTING OF MOVING COIL PANEL METER	2 5 FEB 2004	PAGE 1	OF 10

1. SCOPE

1.1 Service Request No : ERTL (W) / 20022611 dated 31-Dec.-2002

1.1.1 Service Request finalised on: : 31-Dec.-2002.

1.2 Requested by : MECO INSTRUMENTS PVT LTD., (Name and address of organisation) 301, BHARAT INDUSTRIAL EASTATE,

T.J. ROAD, SEWREE (W),

MUMBAI - 400 015.

1.3 <u>Description</u> <u>Oty Manufacturer</u> Model <u>Serial Nos.</u>

MOVING COIL 03 Nos. MECO M 72 3330/3 - SAMPLE 1 (S-1) PANEL METER, 3331/3 - SAMPLE 2 (S-2) 0 - 20 A DC. 3332/3 - SAMPLE 3 (S-3)

CLASS - 1.5

2nd set of samples

4934/3 - SAMPLE 1 (S-1)

4935/3 - SAMPLE 2 (S-2) 4936/3 - SAMPLE 3 (S-3)

1.4 Test specifications AS PER IS 1248:1993, CATEGORY II

1.5 Lab Ambient Temperature : (25 ±2) deg.C

Humidity : (55 ± 5) % RH

1.6 Condition of items on receipt: Good.

1.7 Test Equipment used: 1. Calibration System S&C/138

D.M.M
 Digital Insulation Tester
 W/I Auto Tester
 E&S/121
 W/I Auto Tester
 Environmental Chamber
 Environmental Chamber
 WK 1000-2

7. Vibration Machine ENV/008

8. Shock Test Machine ENV/018



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ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF INFORMATION TECHNOLOGY (STOC Die)	SUBJECT: LESTING MOVING COIL PANEL METER	

2.0 Test Results

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Remark	Complied	i		Complied	•	Complied	•					e.		Complied					Complied	\ <u>'</u>		(S)(S)	(5/6°C
	S-3	> 2000	M ohm	shover		S-3	0.3 %	-0.5 %	-1.1%	-0.95 %				S-3	0.2 %	0.1%	0.2 %	0.3 %		0.3 %	0.2 %	0.7 %	0.15%
Observation	Z-S	> 2000	M ohm	No breakdown or flashover	observed.	S-2	-0.15 %	-0.45 %	-0.15 %	-0.15 %				S-2	0.2 %	0.5 %	0.2 %	0.85 %		0.1%	0.15 %	0.35 %	0.25 %
	I-S	> 2000	M ohm	No brea		S - 1	0.85 %	0.1%	-0.2 %	-0.05 %				S-1	% 59.0	0.55%	0.5%	0.85 %		0.2 %	0.25 %	0.3 %	0.3 %
Requirement	Not less than 5 M ohm			There shall not be any	breakdown/ flashover.	Class index (1.5%)								Permissible variation shall be 100% of class index					Permissible variation shall be 100% of class index				
Test Condition	At 500 V DC for 1 min. between terminals	shorted together and body.		AT 3 kV AC rms for 1 min. between terminals	shorted together and foil wrapped on body.	At following equidistant points	5A	10 A	15 A	19 A				Lower temp. 10 deg. C, Upper temp. 37 deg.C Intrinsic error checked at following equidistant	points. 5A		15 A	19 A	Lower Relative humidity 25%, Upper Relative humidity 80% Intrinsic error checked at	following equidistant points. 5 A		15 A	19 A
Test/Parameter	Insulation	Resistance		High Voltage	Test	Intrinsic Error					Variation due	to influencial	quantities	Variation due to ambient	temp.	•			Variation due to humidity				
Sr.No.	2.1			2.2		2.3	-				2.4			2.4.1					2.4.2				

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Remark	Complied	4	Complied					Complied		Complied			1	% () () () () () () () () () (
	S-3	% 0		0.25 %	0.3 %	0.15%	0.25 %	0.25 %			0.3 %	0.35 %	0.05 %	0.15 %
Observation	S-2	%0		0.3 %	0.3 %	0.35 %	0.15 %	0.2 %		· .	0.25 %	0.2 %	0.35 %	0.3 %
	S-1	%0		0.2 %	0.2 %	0.15 %	0.15 %	0.25 %			0.05 %	0.05 %	0.1%	% 0
Requirement	Permissible variation shall be	50% of class index	Permissible variation shall be 50% of class index					6 % of fiducial value		Within the limit of intrinsic error				
Test Condition	Superimpose 20 % of third harmonics up on	the fundamental wave form.	Intrinsic error to be measured at reference plane and then at 5 deg. Inclination plane in forward, backward, left & right direction. Maximum deviation at following equidistant	points. 5A	10 A	15 A	19 A	AC excitation of upper limit under an external magnetic field of 0.4kA/m. Maximum deviation to be observed.		Accuracy test carried out by mounting UUT on Non Ferrous Panel (PVC) & Ferrous Panel at following equidistant points		10 A	15 A	19 A
Test/Parameter	Variation due	to distortion of AC measured quantity	Variation due to position					2.4.6 Variation due to magnetic field of	external origin	Variation due to ferromagnetic	supports			
Sr.No.	2.4.3		2.4.5					2.4.6	,	2.4.7				

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Remark	Complied								Complied		Complied		Complied		Complied				•	TOO!	Tool Sol	10 × 10 × 10 × 10 × 10 × 10 × 10 × 10 ×
		4		0.25 %	-0.55 %	-1.15 %	-1.05 %	-	No	overshoot	on of rest		S-3	0.35 %	erved			S-3	0.3 %	-0.5 %	-1.1%	-1.25 %
Observation				% 8·0-	-1.0%	-0.4 %	-0.4 %		No	overshoot	Indices reached the position of rest	each case	S-2	0.3 %	No residual deflection observed			S-2	-0.55 %	-0.5 %	-0.5 %	-0.55 %
				0.25 %	-0.4%	-0.55 %	-0.35 %		No	overshoot	Indices reach	within 4s in each case	S-1	0.3 %	No residual			S-1	0.35 %	-0.15 %	-0.35 %	-0.4%
Requirement	Shall meet the requirement of	intrinsic error							Shall not exceed 20% of scale	length	Within 1.5% scale length after	4 s.	Shall comply with the	requirements of class index.	a) Residual deflection shall	not exceed 1% of scale	length		b) Shall comply with the	accuracy requirement.		
Test Condition	Accuracy test carried out by mounting UUT	on conductive support tollowing equidistant	points	5 A	10 A	15 A	19 A		By suddenly applying 2/3 rd of measuring	range & note down the % overshoot.	By suddenly applying 2/3 rd of measuring	range & note down time (sec).		range for 30 to 35 min. & note down the deviation (%)	a) By applying 120% of upper limit for 2h		b) Accuracy test at following equidistant	points after 2 h.	5 A	10 A	15 A	19 A
Sr.No. Test/Parameter	Variation due	to conductive	supports					Damping	Mechanical	overshoot	Response time		Self Heating		Continuous	overload						
Sr.No.	2.4.8							2.5	2.5.1		2.5.2		2.6		2.7							

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Remark	l		-					7.44.0								Complied	•	13		* <i>'8</i> /03/
	est facility							100	2 2							S-3	0.65%	-0.25 %	-1.15 %	-0.1%
Observation	Test not done due to test facility limitation.							Conditioned.	hange.							S-2	-0.2%	-0.3 %	0.1%	0.3 %
	Test not de							Conditioned.	excitation change.							S-1	0.85 %	0.1%	0.05 %	-0.05 %
Requirement	Deviation of index from zero scale mark shall not exceed 0.5% of scale length	b) Shall comply with accuracy	requirements.					To be conditioned								Error shall be within class index	(1.5%)			
Test Condition	a) Apply 200 A DC for 0.5s nine times at a) an interval of 60s and once for 5s.	b) Accuracy test at the following equidistant points:		10 A	15 A 19 A			55 deg.C for 16h & -10 deg.C for 8h. 3 cycles while at 80% of the immer limit of	excitation. During the last cycle at the end	of 16h and while at high temp. slowly	increase & decrease the excitation until	72	lauge & return to zero. Similarly after 8h at lauge teams cloudy increase & decrease the	excitation until index reaches the upper	limit of measuring range & return to zero.			10 A	15A	19 A
Test/Parameter	Overloads of short duration					Environmental	Tests	Temp. cycling								Post	Measurement	Intrinsic error		
St.No.	8					2.9		2.9.1					,			2.6.2				

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Remark	****			Complied					Complied				
				S-3	0.65 %	-0.25 %	-1.15 %	-0.17%	erved				
Observation	Conditioned			S-2	-0.2 %	-0.3 %	0.1%	0.3 %	No deviation observed				
)				S-1	0.85 %	0.1%	0.05 %	-0.05 %	No de				
								-	as	shall	y of		•
Requirement	To be conditioned			(1.5%)					expressed	of scale length	not exceed more than 50% of		
N R	Tol			Class index (1.5%)					Deviation			class index.	
Test Condition	As per IS 9000. Part 5 Sec. 1 (16+8) h)	cycle.	2 cycles. Recovery 24 h.	At the following equidistant points:	5 A	10 A	15A	19 A	Energise the samples for 30s at upper limit Deviation		excitation to zero. Deviation from zero	shall be measured 15s after the excitation	has been reduced to zero.
Sr.No. Test/Parameter	Damp Heat	Cyclic Test		Post	Measurement	Intrinsic error			2.10 Deviation from	zero			
Sr.No.	2.9.3	,		2.9.4					2.10				



ELECTRONICS REGIONAL TEST LABORATORY (WEST)	SECOND (VIX) IL GH ON LOUDED	3C3-8-EC00C/ (X)	y.
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Remark		Not	Complied			
	bserved	S-3	1.35 %	2.65 %	1.95 %	2.63 %
Observation	Conditioned No visual damage observed	S-2	0.1 %	0.7%	0.7%	0.45 %
	No visus	S-1	%0	%0	0.4 %	0.15%
Requirement	To be conditioned	Error shall not deviate more than	50% of class index			
Test Condition	As per IS 9000 Part 8 Sweep range: 10-150-10 Hz Displacement amplitude: 0.15 mm peak in the range 10-60 Hz, Acceleration: 2g in the range: 60-150 Hz, Sweep Rate: 1 octave/min., Duration: 6 h. Endurance shall be performed at resonance frequency. Vibration shall be applied at the resonance frequency for 6h in that direction. If the resonance is observed in any of these 3 directions, the equipment shall be subjected to vibration at each of the frequencies 25, 50, 100 and 150 Hz in each of the 3 mutually perpendicular direction so that the total duration shall not exceed 6 h.	At the following equidistant points:	5A	10 A	15 A	19 A
Test/Parameter	Vibration test	Accuracy Test	(Post	Vibration)		
Sr.No.	2.11	2.12		,		

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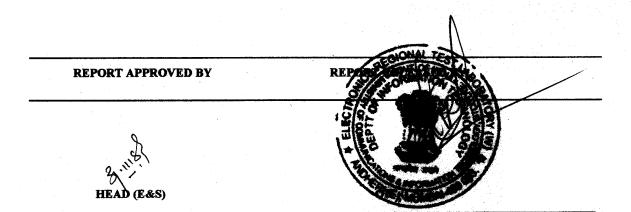
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Remark		!	Complied	•		1	
		bserved	S-3	%0	0.1%	0.05 %	%10
Observation		Conditioned No visual damage observed	S-2	0.1%	0.15 %	0.3 %	0.15 %
		No visu	S-1	0.15 %	0.7 %	0.1%	0.3 %
Requirement		To be conditioned	Error shall not deviate more than	50% of class index			
Test Condition	samples	As per IS 9000 Part 8 Sweep range: 10-150-10 Hz Displacement amplitude: 0.15 mm peak in the range 10-60 Hz, Acceleration: 2g in the range: 60-150 Hz, Sweep Rate: 1 octave/min., Duration: 6 h. Endurance shall be performed at resonance frequency. Vibration shall be applied at the resonance frequency for 6h in that direction. If the resonance is observed in any of these 3 directions, the equipment shall be subjected to vibration at each of the frequencies 25, 50, 100 and 150 Hz in each of the 3 mutually perpendicular direction so that the total duration shall not exceed 6 h.	At the following equidistant points:	5 A	10 A	15 A	19 A
Sr.No. Test/Parameter	Test results of 2nd set of samples	Vibration test	Accuracy Test	(Post	Vibration)		
Sr.No.	Test resu	2.13	2.14				

					18
Remark	1	Complied		Complied	THEODY.
		S-3 0.05 % 0.05 % 0.2 %		S-3 -0.35 % -0.75 %	-0.7%
Observation	Conditioned	S-2 0.15% 0.1% 0.0%	Conditioned	S-2 -0.3 % -0.35 %	-0.85 %
	-	S-1 0.2% 0.2% 0.1%		S-1 -0.25 % -0.95 %	-0.75%
Requirement	To be conditioned	Error after test shall not deviate by more than 100% of class index from the original values measured before shock test.	To be conditioned	Error shall be within class index (1.5 %)	
Test Condition	As per IS 9000 P-7, Peak Acceleration: 15g, Pulse shape: half sine, Duration: 11 ms, 3 shocks in both directions of 3 mutually	idistant points: 5 A 10 A 15 A 15 A 15 A 15 A 19 A 19 A 19 A 19	The UUT shall be subjected to 1,50,000 full scale deflections, the impulse supplied being of such amplitude that the pointer reaches max. value of the scale without impinging on the end stop. ON for 1 sec OFF for 4 sec during one cycle.	At the following equidistant points: 5 A 10 A	13 A 19 A
Test/Parameter	Shock Test	Accuracy Test (Post Shock)	Life Test	Accuracy Test (Post Life Test)	
Sr.No.	2.15	2.16	2.17	2.18	

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3.0 General Remarks:

- 3.1 The sample S3 failed to meet deviation requirement for accuracy test (post vibration) Sr. No. 2.12. Further set of fresh 3 samples submitted by customer.
- 3.2 The fresh set of 3 samples taken for testing from Sr. No. 2.13 onward and result are reported.



OUR ACCREDITATION STATUS

ERTL (W) set up under the STQC Directorate, Ministry of Communications & Information Technology, Govt. of India has been accreditated under number of national / international systems as follows:

SYSTEM	AREA	STATUS
IECQ (International Electro-technical Commission on Quality Assessment System for Electronic Components)	Component Testing Resistors (Fixed) Capacitors (Fixed)	Accreditated as ITL (Independent Test Laboratory)
NABL (C), India National Accreditational Board for Test & Calibration laboratories (Calibration System)	Calibration Electro-technical discipline Thermal discipline Mechanical discipline	Accreditated Calibration Laboratory
NABL(T), India National Accreditational Board for Test & Calibration laboratories (Testing System)	Electronic & Electrical Testing	Accreditated Test Laboratory
IECEE-CE-Scheme	Mains Operated Electronic Consumer Products	Approved as a CB test Laboratory
Other recognisation		Recognised by CSPO of State Govt., DOT, Naval Docyard, LCSO etc.